# **LP3999**

LP3999 Low Noise 150mA Voltage Regulator for RF/Analog Applications



Literature Number: SNVS207D



# **LP3999**

# Low Noise 150mA Voltage Regulator for RF/Analog Applications

# **General Description**

The LP3999 regulator is designed to meet the requirements of portable wireless battery-powered applications and will provide an accurate output voltage with low noise and low quiescent current. Ideally suited for powering RF/Analog devices this device will also be used to meet more general circuit requirements.

For battery powered applications the low dropout and low ground current provided by the device allows the lifetime of the battery to be maximized. The inclusion of an Enable (disable) control can be used by the system to further extend the battery lifetime by reducing the power consumption to virtually zero. Should the application require a device with an active disable function please refer to device LP3995.

The LP3999 also features internal protection against short-circuit currents and over-temperature conditions.

The LP3999 is designed to be stable with small 1.0  $\mu$ F ceramic capacitors. The small outline of the LP3999 micro SMD package with the required ceramic capacitors can realize a system application within minimal board area.

Performance is specified for a  $-40^{\circ}$ C to  $+125^{\circ}$ C temperature range.

The device is available in micro SMD package. For other package options contact your local NSC sales office.

The device is available in fixed output voltages in the ranges of 1.5V to 3.3V. For availability, please contact your local NSC sales office.

# **Key Specifications**

- 2.5V to 6.0V Input Range
- Accurate Output Voltage; ±75mV / 2%
- 60 mV Typical Dropout with 150 mA Load. V<sub>out</sub> > 2.5V
- Virtually Zero Quiescent Current when Disabled
- 10 µVrms output noise over 10Hz to 100kHz
- Stable with a 1 µF Output Capacitor
- Guaranteed 150 mA Output Current
- Fast Turn-on Time; 140 µs (Typ.)

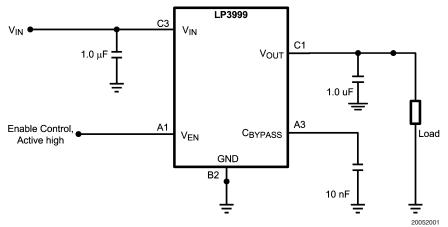
#### **Features**

- 5 pin micro SMD Package
- Stable with Ceramic Capacitor
- Logic Controlled Enable
- Fast Turn-on
- Thermal-overload and short-circuit protection
- -40 to +125°C junction temperature range for operation

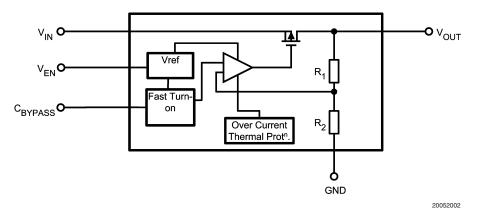
# **Applications**

- GSM Portable Phones
- CDMA Cellular Handsets
- Wideband CDMA Cellular Handsets
- Bluetooth Devices
- Portable Information Appliances
- Handheld MP3 Devices

# **Typical Application Circuit**



# **Block Diagram**



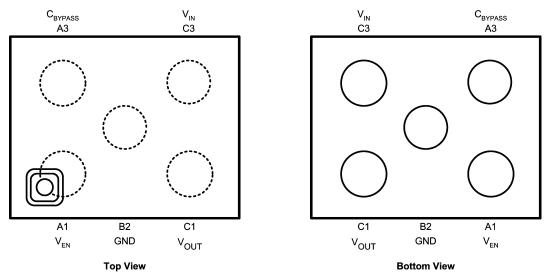
# **Pin Descriptions**

# Package 5-pin microSMD

Pin No.	Symbol	Name and Function
A1	V <sub>EN</sub>	Enable Input; Disables the Regulator when ≤ 0.4V.
		Enables the regulator when ≥ 0.9V
B2	GND	Common Ground
C1	V <sub>OUT</sub>	Voltage output. Connect this output to the load circuit.
C3	V <sub>IN</sub>	Voltage Supply Input
A3	C <sub>BYPASS</sub>	Bypass Capacitor connection.
		Connect a 0.01 µF capacitor for noise reduction.

# **Connection Diagram**

## micro SMD, 5 Bump Package



See NS Package Number TLA05

2

# **Ordering Information**

## For micro SMD Package

Output Voltage (V)	Grade	LP3999 Supplied as 250 Units, Tape and Reel	LP3999 Supplied as 3000 Units, Tape and	Package Marking
			Reel	
1.5	STD	LP3999ITL-1.5	LP3999ITLX-1.5	
1.8	STD	LP3999ITL-1.8	LP3999ITLX-1.8	
1.875	STD	LP3999ITL-1.875	LP3999ITLX-1.875	
2.4	STD	LP3999ITL-2.4	LP3999ITLX-2.4	
2.5	STD	LP3999ITL-2.5	LP3999ITLX-2.5	
2.8	STD	LP3999ITL-2.8	LP3999ITLX-2.8	
3.3	STD	LP3999ITL-3.3	LP3999ITLX-3.3	

## For micro SMD Package UNLEADED

Output Voltage (V)	Grade	LP3999 Supplied as 250 Units, Tape and Reel	LP3999 Supplied as 3000 Units, Tape and Reel	Package Marking
1.5	STD	LP3999ITL-1.5 NOPB	LP3999ITLX-1.5 NOPB	
1.8	STD	LP3999ITL-1.8 NOPB	LP3999ITLX-1.8 NOPB	
1.875	STD	LP3999ITL-1.875 NOPB	LP3999ITLX-1.875 NOPB	
2.4	STD	LP3999ITL-2.4 NOPB	LP3999ITLX-2.4 NOPB	
2.5	STD	LP3999ITL-2.5 NOPB	LP3999ITLX-2.5 NOPB	
2.8	STD	LP3999ITL-2.8 NOPB	LP3999ITLX-2.8 NOPB	
3.3	STD	LP3999ITL-3.3 NOPB	LP3999ITLX-3.3 NOPB	

# **Absolute Maximum Ratings**

(Notes 1, 2)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/ Distributors for availability and specifications.

 $\begin{array}{cc} \text{Input Voltage (V}_{\text{IN}}) & -0.3 \text{ to } 6.5 \text{V} \\ \text{Output Voltage} & -0.3 \text{ to (V}_{\text{IN}} + 0.3 \text{V}) \end{array}$ 

to 6.5V (max)

Enable Input Voltage -0.3 to 6.5V Junction Temperature 150°C

Lead/Pad Temperature

(Note 3)

microSMD 260°C

Storage Temperature -65 to +150°C Continuous Power Dissipation Internally limited

(Note 4) ESD (Note 7) Human Body Model 2 kV Machine Model 200V

# Operating Ratings (Note 1)

(Note 5)

# Thermal Properties(Note 6)

Junction to Ambient Thermal

Resistance

 $\theta_{\rm JA}$  (micro SMD pkg.) 255°C/W

## **Electrical Characteristics**

Unless otherwise noted,  $V_{EN} = 1.5$ ,  $V_{IN} = V_{OUT(NOM)} + 1.0V$ ,  $C_{IN} = 1~\mu\text{F}$ ,  $I_{OUT} = 1~m\text{A}$ ,  $C_{OUT} = 1~\mu\text{F}$ ,  $C_{BP} = 0.01~\mu\text{F}$ . Typical values and limits appearing in normal type apply for  $T_J = 25^{\circ}\text{C}$ . Limits appearing in **boldface** type apply over the full temperature range for operation,  $-40~\text{to} + 125^{\circ}\text{C}$ . (Notes 11, 12)

0	Dawana atau	Conditions	Typical	Limit		Units
Symbol	Parameter			Min	Max	Units
V <sub>IN</sub>	Input Voltage			2.5	6.0	V
DEVICE OUT	ΓΡUT: 1.5 ≤ V <sub>OUT</sub> < 1.8V	•				•
$\Delta V_{OUT}$	Output Voltage Tolerance	I <sub>OUT</sub> = 1 mA		-50	50 <b>75</b>	mV
				-75		
	Line Regulation Error	$V_{IN} = (V_{OUT(NOM)} + 1.0V)$ to 6.0V, $I_{OUT} = 1 \text{ mA}$		-3.5	3.5	mV/V
	Load Regulation Error	I <sub>OUT</sub> = 1 mA to 150 mA	10		75	μV/mA
PSRR	Power Supply Rejection Ratio	f = 1 kHz, I <sub>OUT</sub> = 1 mA	58			-ID
	(Note 9)	f = 10 kHz, I <sub>OUT</sub> = 1 mA	58			- dB
DEVICE OUT	ΓΡUT: 1.8 ≤ V <sub>OUT</sub> < 2.5V					
$\Delta V_{OUT}$	Output Voltage Tolerance	I <sub>OUT</sub> = 1 mA		-50	50	
				-75	75	mV
	Line Regulation Error	$V_{IN} = (V_{OUT(NOM)} + 1.0V)$ to 6.0V, $I_{OUT} = 1 \text{ mA}$		-2.5	2.5	mV/V
	Load Regulation Error	I <sub>OUT</sub> = 1 mA to 150 mA	10		75	μV/mA
PSRR	Power Supply Rejection Ratio	f = 1 kHz, I <sub>OUT</sub> = 1 mA	60			-ID
	(Note 9)	f = 10 kHz, I <sub>OUT</sub> = 1 mA	60			dB
DEVICE OUT	ΓΡUT: 2.5 ≤ V <sub>OUT</sub> ≤ 3.3V					
$\Delta V_{OUT}$	Output Voltage Tolerance	I <sub>OUT</sub> = 1 mA		-2	2	% of
				-3	3	V <sub>OUT(NOM</sub>
	Line Regulation Error	$V_{IN} = (V_{OUT(NOM)} + 1.0V)$ to 6.0V, $I_{OUT} = 1 \text{ mA}$		-0.1	0.1	%/V
	Load Regulation Error	I <sub>OUT</sub> = 1 mA to 150 mA	0.0004		0.002	%/mA
$V_{DO}$	Dropout Voltage	I <sub>OUT</sub> = 1 mA	0.4		2	.,
20		I <sub>OUT</sub> = 150 mA	60		100	mV
PSRR	Power Supply Rejection Ratio	f = 1 kHz, I <sub>OUT</sub> = 1 mA	60			<u> </u>
	(Note 9)	f = 10 kHz, I <sub>OUT</sub> = 1 mA	50			→ dB
FULL V <sub>out</sub> F	RANGE	. 55.				1
I <sub>LOAD</sub>	Load Current	(Notes 8, 9)		0		μА

## **Electrical Characteristics** (Continued)

Unless otherwise noted,  $V_{EN} = 1.5$ ,  $V_{IN} = V_{OUT(NOM)} + 1.0V$ ,  $C_{IN} = 1~\mu\text{F}$ ,  $I_{OUT} = 1~m\text{A}$ ,  $C_{OUT} = 1~\mu\text{F}$ ,  $C_{BP} = 0.01~\mu\text{F}$ . Typical values and limits appearing in normal type apply for  $T_J = 25^{\circ}\text{C}$ . Limits appearing in **boldface** type apply over the full temperature range for operation,  $-40~\text{to} + 125^{\circ}\text{C}$ . (Notes 11, 12)

Cumbal	Devementer	Conditions	Typical	Limit		
Symbol	Parameter			Min	Max	Units
FULL V <sub>OUT</sub> F	RANGE					•
I <sub>Q</sub>	Quiescent Current	V <sub>EN</sub> = 1.5V, I <sub>OUT</sub> = 0 mA	85		150	
		$V_{EN} = 1.5V, I_{OUT} = 150 \text{ mA}$	140		200	μΑ
		V <sub>EN</sub> = 0.4V	0.003		1.5	]
I <sub>sc</sub>	Short Circuit Current Limit		450			mA
E <sub>N</sub>	Output Noise Voltage ((Note 9))	BW = 10 Hz to 100 kHz,	10			
		V <sub>IN</sub> = 4.2V, No Load	10			μVrms
		BW = 10 Hz to 100 kHz,	30			μνιιιιε
		V <sub>IN</sub> = 4.2V, 1mA Load				
$T_{SHUTDOWN}$	Thermal Shutdown	Temperature	160			°C
		Hysteresis	20			
ENABLE CO	NTROL CHARACTERISTICS					
I <sub>EN</sub>	Maximum Input Current at	$V_{EN} = 0.0V$ and $V_{IN} = 6.0V$	0.001			μA
	V <sub>EN</sub> Input		0.001			μΛ
$V_{IL}$	Low Input Threshold				0.4	V
V <sub>IH</sub>	High Input Threshold			0.9		V
TIMING CHA	RACTERISTICS					
T <sub>ON</sub>	Turn On Time (Note 9)	To 95% Level (Note 10)	140			μs

**Note 1:** Absolute Maximum Ratings are limits beyond which damage to the device may occur. Operating Ratings are conditions under which operation of the device is guaranteed. Operating Ratings do not imply guaranteed performance limits. For guaranteed performance limits and associated test conditions, see the Electrical Characteristics tables.

Note 2: All voltages are with respect to the potential at the GND pin.

Note 3: For further information on these packages please refer to the following application notes;

AN-1112 Micro SMD Package Wafer Level Chip Scale Package.

Note 4: Internal Thermal shutdown circuitry protects the device from permanent damage.

Note 5: In applications where high power dissipation and/or poor thermal resistance is present, the maximum ambient temperature may have to be derated. Maximum ambient temperature  $(T_{J(max-op)})$ , is dependant on the maximum operating junction temperature  $(T_{J(max-op)})$ , the maximum power dissipation  $(P_{D(max)})$ , and the junction to ambient thermal resistance in the application  $(\theta_{JA})$ . This relationship is given by :-

$$T_{A(max)} = T_{J(max-op)} - (P_{D(max)} \times \theta_{JA})$$

Note 6: Junction to ambient thermal resistance is highly dependant on the application and board layout. In applications where high thermal dissipation is possible, special care must be paid to thermal issues in the board design.

Note 7: The human body is 100 pF discharge through 1.5  $k\Omega$  resistor into each pin. The machine model is a 200 pF capacitor discharged directly into each pin.

Note 8: The device maintains the regulated output voltage without load.

Note 9: This electrical specification is guaranteed by design.

Note 10: Time from  $V_{EN} = 0.9V$  to  $V_{OUT} = 95\%$  ( $V_{OUT(NOM)}$ )

Note 11: All limits are guaranteed. All electrical characteristics having room-temperature limits are tested during production at  $T_J = 25^{\circ}C$  or correlated using Statistical Quality Control methods. Operation over the temperature specification is guaranteed by correlating the electrical characteristics to process and temperature variations and applying statistical process control.

Note 12: V<sub>OUT(NOM)</sub> is the stated output voltage option for the device.

# **Recommended Output Capacitor**

Symbol	Parameter	Conditions	Typical	Limit		Units
	raianietei			Min	Max	Units
C <sub>OUT</sub>	Output Capacitor	Capacitance (Note 13)	1.0	0.70		μF
		ESR		5	500	mΩ

Note 13: The capacitor tolerance should be 30% or better over temperature. Recommended capacitor type is X7R however dependant on application X5R,Y5V and Z5U can also be used.

# **Input Test Signals**

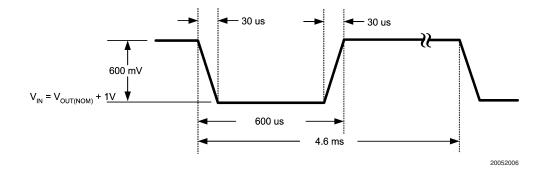


FIGURE 1. Line Transient Response Input Test Signal

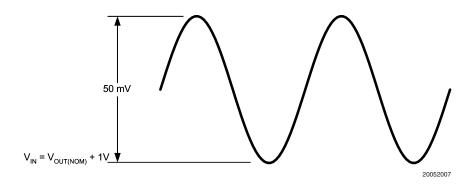
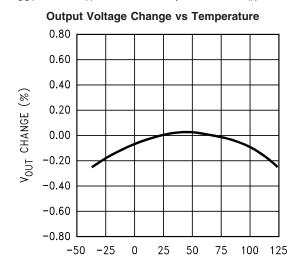
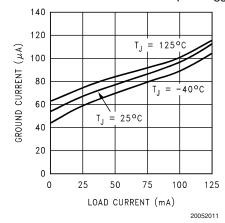


FIGURE 2. PSRR Input Test Signal

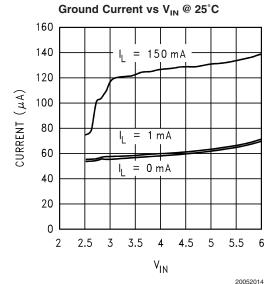
# **Typical Performance Characteristics** Unless otherwise specified, $C_{IN} = C_{OUT} = 1.0 \ \mu F$ Ceramic, $V_{IN} = V_{OUT} + 1.0 V$ , $T_A = 25 \ C$ , Enable pin is tied to $V_{IN}$ .



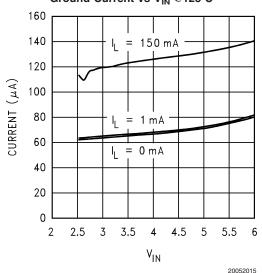
#### Ground Current vs Load Current (1.8V VOUT)

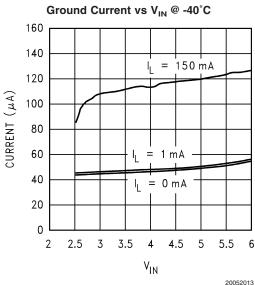


TEMPERATURE (°C) 20052010

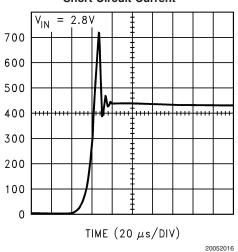


Ground Current vs  $V_{\text{IN}}$  @125°C

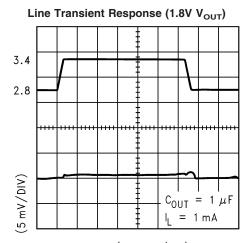




**Short Circuit Current** 

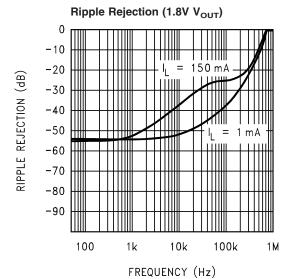


# Typical Performance Characteristics Unless otherwise specified, $C_{IN} = C_{OUT} = 1.0 \mu F$ Ceramic, $V_{IN} = V_{OUT} + 1.0V$ , $T_A = 25^{\circ}C$ , Enable pin is tied to $V_{IN}$ . (Continued)

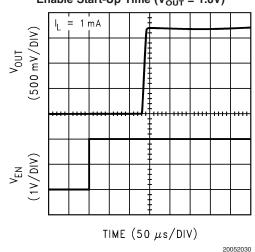


TIME (100  $\mu$ s/DIV)

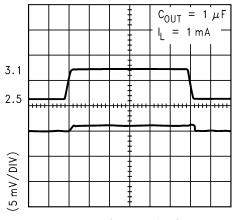
20052018



# Enable Start-Up Time (V<sub>OUT</sub> = 1.8V)



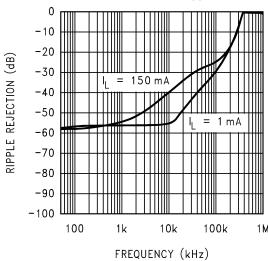
#### Line Transient Response (1.5V V<sub>OUT</sub>)



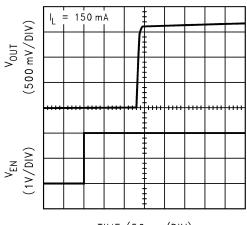
TIME (100  $\mu$ s/DIV)

20052017

### Ripple Rejection (1.5V V<sub>OUT</sub>)



Enable Start-Up Time (V<sub>OUT</sub> = 1.8V)

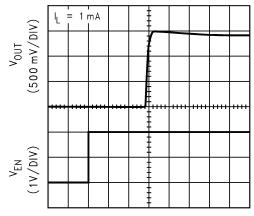


TIME (50  $\mu$ s/DIV)

20052031

# Typical Performance Characteristics Unless otherwise specified, $C_{IN}$ = $C_{OUT}$ = 1.0 $\mu$ F Ceramic, $V_{IN}$ = $V_{OUT}$ + 1.0V, $T_A$ = 25°C, Enable pin is tied to $V_{IN}$ . (Continued)

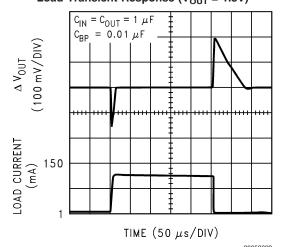


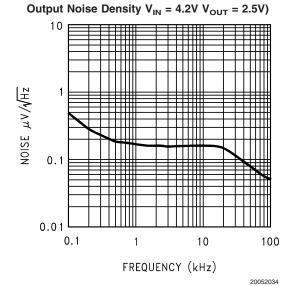


TIME (50  $\mu$ s/DIV)

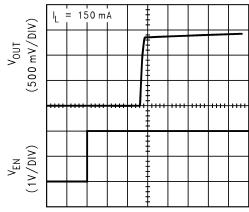
2005203

# Load Transient Response (V<sub>OUT</sub> = 1.8V)





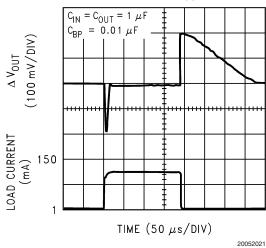
## Enable Start-Up Time ( $V_{OUT} = 1.5V$ )



TIME (50  $\mu$ s/DIV)

20052033

## Load Transient Response (V<sub>OUT</sub> = 1.5V)



# **Application Hints**

#### POWER DISSIPATION AND DEVICE OPERATION

The permissible power dissipation for any package is a measure of the capability of the device to pass heat from the power source, the junctions of the IC, to the ultimate heat sink, the ambient environment. Thus the power dissipation is dependent on the ambient temperature and the thermal resistance across the various interfaces between the die and ambient air.

Re-stating the equation given in (Note 5) in the electrical specification section, the allowable power dissipation for the device in a given package can be calculated:

$$P_{D} = \frac{(T_{J(MAX)} - T_{A})}{\theta_{JA}}$$

With a  $\theta_{JA}$  = 255°C/W, the device in the micro SMD package returns a value of 392 mW with a maximum junction temperature of 125°C.

The actual power dissipation across the device can be represented by the following equation:

$$\mathsf{P}_\mathsf{D} = (\mathsf{V}_\mathsf{IN} - \mathsf{V}_\mathsf{OUT}) \; \mathsf{x} \; \mathsf{I}_\mathsf{OUT}.$$

This establishes the relationship between the power dissipation allowed due to thermal consideration, the voltage drop across the device, and the continuous current capability of the device. These two equations should be used to determine the optimum operating conditions for the device in the application.

#### **EXTERNAL CAPACITORS**

In common with most regulators, the LP3999 requires external capacitors to ensure stable operation. The LP3999 is specifically designed for portable applications requiring minimum board space and smallest components. These capacitors must be correctly selected for good performance.

#### **INPUT CAPACITOR**

An input capacitor is required for stability. It is recommended that a 1.0  $\mu$ F capacitor be connected between the LP3999 input pin and ground (this capacitance value may be increased without limit).

This capacitor must be located a distance of not more than 1 cm from the input pin and returned to a clean analogue ground. Any good quality ceramic, tantalum, or film capacitor may be used at the input.

**Important:** Tantalum capacitors can suffer catastrophic failures due to surge current when connected to a low-impedance source of power (like a battery or a very large capacitor). If a tantalum capacitor is used at the input, it must be guaranteed by the manufacturer to have a surge current rating sufficient for the application.

There are no requirements for the **ESR** (Equivalent Series Resistance) on the input capacitor, but tolerance and temperature coefficient must be considered when selecting the capacitor to ensure the capacitance will remain  $\cong 1.0~\mu F$  over the entire operating temperature range.

#### **OUTPUT CAPACITOR**

The LP3999 is designed specifically to work with very small ceramic output capacitors. A ceramic capacitor (dielectric types Z5U, Y5V or X7R) in the 1.0 [to 10  $\mu$ F] range, and with ESR between 5 m $\Omega$  to 500 m $\Omega$ , is suitable in the LP3999 application circuit.

For this device the output capacitor should be connected between the  $\rm V_{\rm OUT}$  pin and ground.

It may also be possible to use tantalum or film capacitors at the device output,  $V_{\text{OUT}}$ , but these are not as attractive for reasons of size and cost (see the section Capacitor Characteristics).

The output capacitor must meet the requirement for the minimum value of capacitance and also have an ESR value that is within the range 5 m $\Omega$  to 500 m $\Omega$  for stability.

#### **NO-LOAD STABILITY**

The LP3999 will remain stable and in regulation with no external load. This is an important consideration in some circuits, for example CMOS RAM keep-alive applications.

#### CAPACITOR CHARACTERISTICS

The LP3999 is designed to work with ceramic capacitors on the output to take advantage of the benefits they offer. For capacitance values in the range of 1  $\mu\text{F}$  to 4.7  $\mu\text{F}$ , ceramic capacitors are the smallest, least expensive and have the lowest ESR values, thus making them best for eliminating high frequency noise. The ESR of a typical 1  $\mu\text{F}$  ceramic capacitor is in the range of 20 m $\Omega$  to 40 m $\Omega$ , which easily meets the ESR requirement for stability for the LP3999.

The temperature performance of ceramic capacitors varies by type. Most large value ceramic capacitors (  $\geq 2.2~\mu F$ ) are manufactured with Z5U or Y5V temperature characteristics, which results in the capacitance dropping by more than 50% as the temperature goes from 25°C to 85°C.

A better choice for temperature coefficient in a ceramic capacitor is X7R. This type of capacitor is the most stable and holds the capacitance within  $\pm 15\%$  over the temperature range. Tantalum capacitors are less desirable than ceramic for use as output capacitors because they are more expensive when comparing equivalent capacitance and voltage ratings in the 1  $\mu$ F to 4.7  $\mu$ F range.

Another important consideration is that tantalum capacitors have higher ESR values than equivalent size ceramics. This means that while it may be possible to find a tantalum capacitor with an ESR value within the stable range, it would have to be larger in capacitance (which means bigger and more costly) than a ceramic capacitor with the same ESR value. It should also be noted that the ESR of a typical tantalum will increase about 2:1 as the temperature goes from 25°C down to -40°C, so some guard band must be allowed.

#### **NOISE BYPASS CAPACITOR**

A bypass capacitor should be connected between the  $C_{\text{BY-PASS}}$  pin and ground to significantly reduce the noise at the regulator output. This device pin connects directly to a high impedance node within the bandgap reference circuitry. Any significant loading on this node will cause a change on the regulated output voltage. For this reason, DC leakage current through this pin must be kept as low as possible for best output voltage accuracy.

The use of a  $0.01\mu F$  bypass capacitor is strongly recommended to prevent overshoot on the output during start-up.

## Application Hints (Continued)

The types of capacitors best suited for the noise bypass capacitor are ceramic and film. High quality ceramic capacitors with NPO or COG dielectric typically have very low leakage. Polypropolene and polycarbonate film capacitors are available in small surface-mount packages and typically have extremely low leakage current.

Unlike many other LDO's, the addition of a noise reduction capacitor does not effect the transient response of the device.

#### **ENABLE OPERATION**

The LP3999 may be switched ON or OFF by a logic input at the ENABLE pin,  $V_{\rm EN}.$  A high voltage at this pin will turn the device on. When the enable pin is low, the regulator output is off and the device typically consumes 3 nA. If the application does not require the shutdown feature, the  $V_{\rm EN}$  pin should be tied to  $V_{\rm IN}$  to keep the regulator output permanently on. To ensure proper operation, the signal source used to drive the  $V_{\rm EN}$  input must be able to swing above and below the specified turn-on/off voltage thresholds listed in the Electrical Characteristics section under  $V_{\rm IL}$  and  $V_{\rm IH}.$ 

#### **FAST TURN ON**

Fast turn-on is guaranteed by control circuitry within the reference block allowing a very fast ramp of the output voltage to reach the target voltage. There is no active turn-off on this device. Refer to LP3995 for a similar device with active turn-off.

#### microSMD MOUNTING

The micro SMD package requires specific mounting techniques which are detailed in National Semiconductor Application Note AN-1112.

Referring to the section *Surface Mount Technology (SMT)* Assembly Considerations, it should be noted that the pad style which must be used with the 5 pin package is NSMD (non-solder mask defined) type.

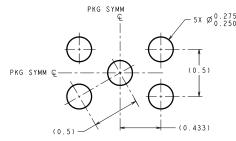
For best results during assembly, alignment ordinals on the PC board may be used to facilitate placement of the micro SMD device.

#### microSMD LIGHT SENSITIVITY

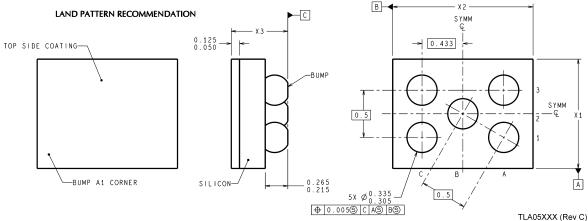
Exposing the micro SMD device to direct sunlight will cause incorrect operation of the device. Light sources such as halogen lamps can affect electrical performance if they are situated in proximity to the device.

Light with wavelengths in the red and infra-red part of the spectrum have the most detrimental effect thus the fluorescent lighting used inside most buildings has very little effect on performance. Tests carried out on a micro SMD test board showed a negligible effect on the regulated output voltage when brought within 1 cm of a fluorescent lamp. A deviation of less than 0.1% from nominal output voltage was observed.

## Physical Dimensions inches (millimeters) unless otherwise noted



DIMENSIONS ARE IN MILLIMETERS
DIMENSIONS IN ( ) FOR REFERENCE ONLY



micro SMD, 5 Bump, Package (TLA05)
NS Package Number TLA05ADA
The dimensions for X1, X2 and X3 are given as:
X1 = 1.006 +/- 0.03mm
X2 = 1.438 +/- 0.03mm

X3 = 0.600 +/- 0.075mm

National does not assume any responsibility for use of any circuitry described, no circuit patent licenses are implied and National reserves the right at any time without notice to change said circuitry and specifications.

For the most current product information visit us at www.national.com.

#### LIFE SUPPORT POLICY

NATIONAL'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF THE PRESIDENT AND GENERAL COUNSEL OF NATIONAL SEMICONDUCTOR CORPORATION. As used herein:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
- A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

#### **BANNED SUBSTANCE COMPLIANCE**

National Semiconductor follows the provisions of the Product Stewardship Guide for Customers (CSP-9-111C2) and Banned Substances and Materials of Interest Specification (CSP-9-111S2) for regulatory environmental compliance. Details may be found at: www.national.com/quality/green.

Lead free products are RoHS compliant.



National Semiconductor Americas Customer Support Center

Email: new.feedback@nsc.com Tel: 1-800-272-9959

www.national.com

National Semiconductor Europe Customer Support Center Fax: +49 (0) 180-530 85 86

Email: europe.support@nsc.com
Deutsch Tel: +49 (0) 69 9508 6208
English Tel: +44 (0) 870 24 0 2171
Français Tel: +33 (0) 1 41 91 8790

National Semiconductor Asia Pacific Customer Support Center Email: ap.support@nsc.com National Semiconductor Japan Customer Support Center Fax: 81-3-5639-7507 Email: jpn.feedback@nsc.com Tel: 81-3-5639-7560

#### IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or service without notice. Customers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All products are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

TI assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using TI components. To minimize the risks associated with customer products and applications, customers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any TI patent right, copyright, mask work right, or other TI intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information published by TI regarding third-party products or services does not constitute a license from TI to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alteration is an unfair and deceptive business practice. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

TI products are not authorized for use in safety-critical applications (such as life support) where a failure of the TI product would reasonably be expected to cause severe personal injury or death, unless officers of the parties have executed an agreement specifically governing such use. Buyers represent that they have all necessary expertise in the safety and regulatory ramifications of their applications, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of TI products in such safety-critical applications, notwithstanding any applications-related information or support that may be provided by TI. Further, Buyers must fully indemnify TI and its representatives against any damages arising out of the use of TI products in such safety-critical applications.

TI products are neither designed nor intended for use in military/aerospace applications or environments unless the TI products are specifically designated by TI as military-grade or "enhanced plastic." Only products designated by TI as military-grade meet military specifications. Buyers acknowledge and agree that any such use of TI products which TI has not designated as military-grade is solely at the Buyer's risk, and that they are solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI products are neither designed nor intended for use in automotive applications or environments unless the specific TI products are designated by TI as compliant with ISO/TS 16949 requirements. Buyers acknowledge and agree that, if they use any non-designated products in automotive applications, TI will not be responsible for any failure to meet such requirements.

Following are URLs where you can obtain information on other Texas Instruments products and application solutions:

#### Products Applications

Audio www.ti.com/audio Communications and Telecom www.ti.com/communications **Amplifiers** amplifier.ti.com Computers and Peripherals www.ti.com/computers dataconverter.ti.com Consumer Electronics www.ti.com/consumer-apps **Data Converters DLP® Products** www.dlp.com **Energy and Lighting** www.ti.com/energy DSP dsp.ti.com Industrial www.ti.com/industrial Clocks and Timers www.ti.com/clocks Medical www.ti.com/medical Interface interface.ti.com Security www.ti.com/security

Logic Space, Avionics and Defense <u>www.ti.com/space-avionics-defense</u>

Power Mgmt power.ti.com Transportation and Automotive www.ti.com/automotive
Microcontrollers microcontroller.ti.com Video and Imaging www.ti.com/video

RFID <u>www.ti-rfid.com</u>
OMAP Mobile Processors www.ti.com/omap

Wireless Connectivity <u>www.ti.com/wirelessconnectivity</u>

TI E2E Community Home Page <u>e2e.ti.com</u>

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2011, Texas Instruments Incorporated